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## N-Channel PowerTrench<sup>®</sup> SyncFET<sup>™</sup> 30 V, 49 A, 1.8 mΩ

#### Features

- Max  $r_{DS(on)}$  = 1.8 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 30 A
- Max  $r_{DS(on)}$  = 2.0 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 25 A
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

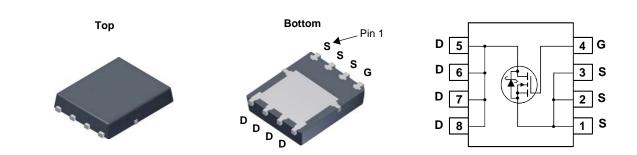


### **General Description**

The FDMS0300S has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

#### Applications

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/ GPU low side switch
- Networking Point of Load low side switch



#### MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			30	V	
V <sub>GS</sub>	Gate to Source Voltage		(Note 4)	±20	V	
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C		49		
	-Continuous (Silicon limited)	T <sub>C</sub> = 25 °C		194		
D	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	31	Α	
	-Pulsed			180		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	242	mJ	
	Power Dissipation	T <sub>C</sub> = 25 °C		96		
P <sub>D</sub>	Power Dissipation $T_A = 25 \text{ °C}$ (Note 1a)			2.5		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C	

#### **Thermal Characteristics**

$R_{\theta J}$	С	Thermal Resistance, Junction to Case		1.3	2 <b>0</b> 0 0 0
$R_{\theta J}$	A	Thermal Resistance, Junction to Ambient	(Note 1a)	50	°C/W

#### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS0300S	FDMS0300S	Power 56	13 "	12 mm	3000 units

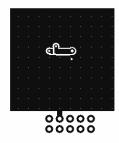
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	octeristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	30			V	
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 10 mA, referenced to 25 °C		19		mV/°C	
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			500	μA	
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA	
On Chara	cteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	1.2	1.6	3.0	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 10$ mA, referenced to 25 °C		-5		mV/°C	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A		1.3	1.8		
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 25 A		1.6	2.0	mΩ	
		$V_{GS}$ = 10 V, $I_{D}$ = 30 A, $T_{J}$ = 125 °C		1.8	2.5		
9fs	Forward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 30 \text{ A}$		161		S	
Dynamic	Characteristics						
C <sub>iss</sub>	Input Capacitance			6545	8705	pF	
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		2465	3280	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			210	315	pF	
R <sub>g</sub>	Gate Resistance			0.5	1.1	Ω	
Switching	g Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time			22	35	ns	
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 30 A,		12	21	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		50	80	ns	
t <sub>f</sub>	Fall Time			7	13	ns	
Qg	Total Gate Charge	$V_{GS} = 0 V$ to 10 V		95	133	nC	
Q <sub>g</sub>	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V},$		43	60	nC	
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 30 A		18.2		nC	
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			9.1		nC	

#### **Drain-Source Diode Characteristics**

V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2 A$ (Note 2)	0.37	0.7	V
		$V_{GS} = 0 V, I_S = 30 A$ (Note 2)	0.74	1.2	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 30 A, di/dt = 300 A/μs	50	81	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$F = 30 \text{ A}, \text{ u/ut} = 300 \text{ A/} \mu \text{s}$	84	136	nC

Notes:

1.  $R_{0,JR}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{0,JC}$  is guaranteed by design while  $R_{0CA}$  is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

b. 125 °C/W when mounted on a minimum pad of 2 oz copper.



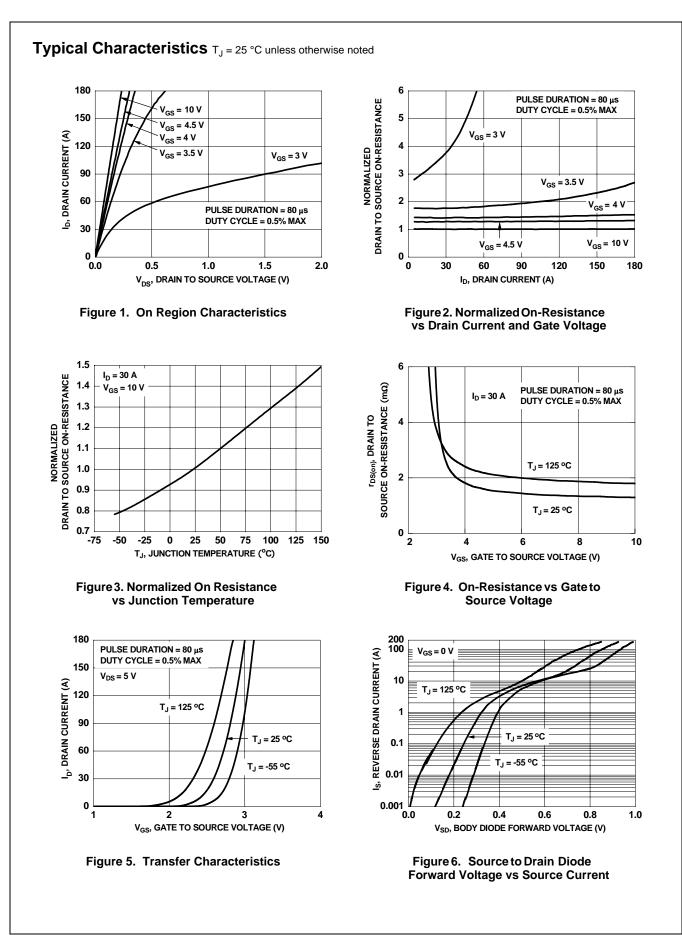


2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.

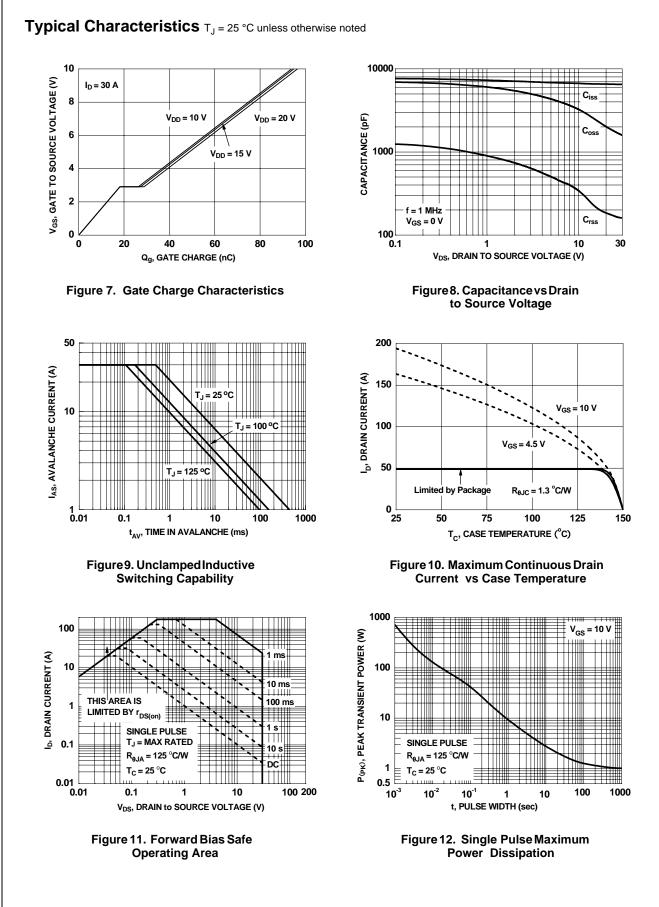
3. E<sub>AS</sub> of 242 mJ is based on starting T<sub>J</sub> = 25 °C, L = 1 mH, I<sub>AS</sub> = 22 A, V<sub>DD</sub> = 27 V, V<sub>GS</sub> = 10 V. 100% test at L = 0.3 mH, I<sub>AS</sub> = 34 A.

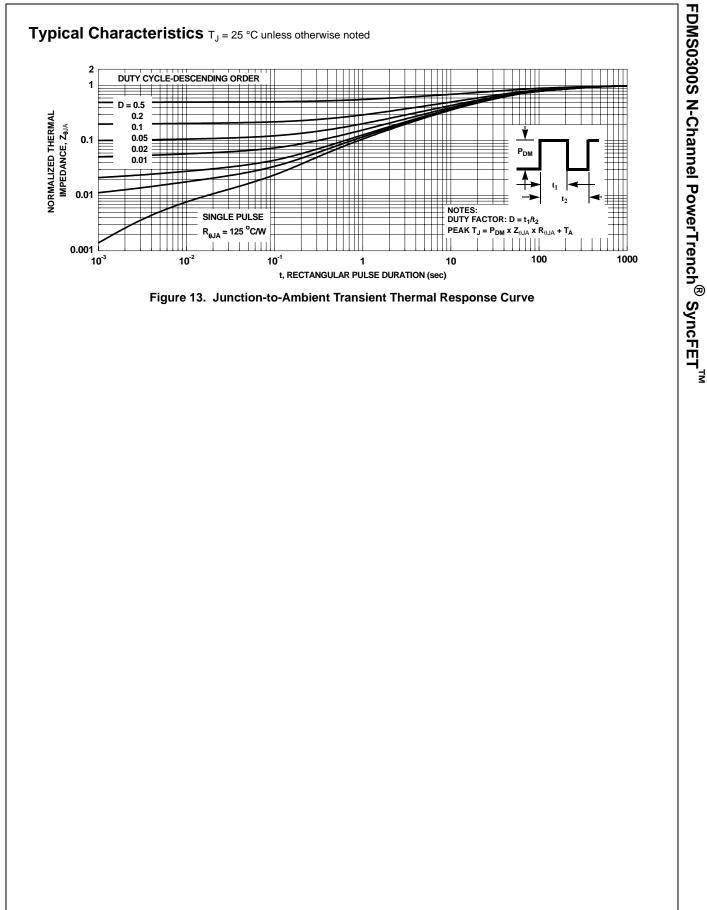
4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

FDMS0300S N-Channel PowerTrench<sup>®</sup> SyncFET<sup>™</sup>









#### Typical Characteristics (continued)

#### SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMS0300S.

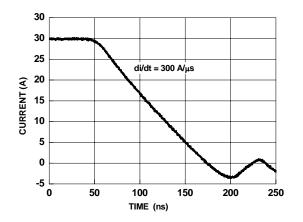


Figure 14. FDMS0300S SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

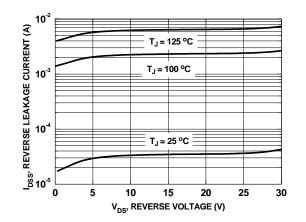
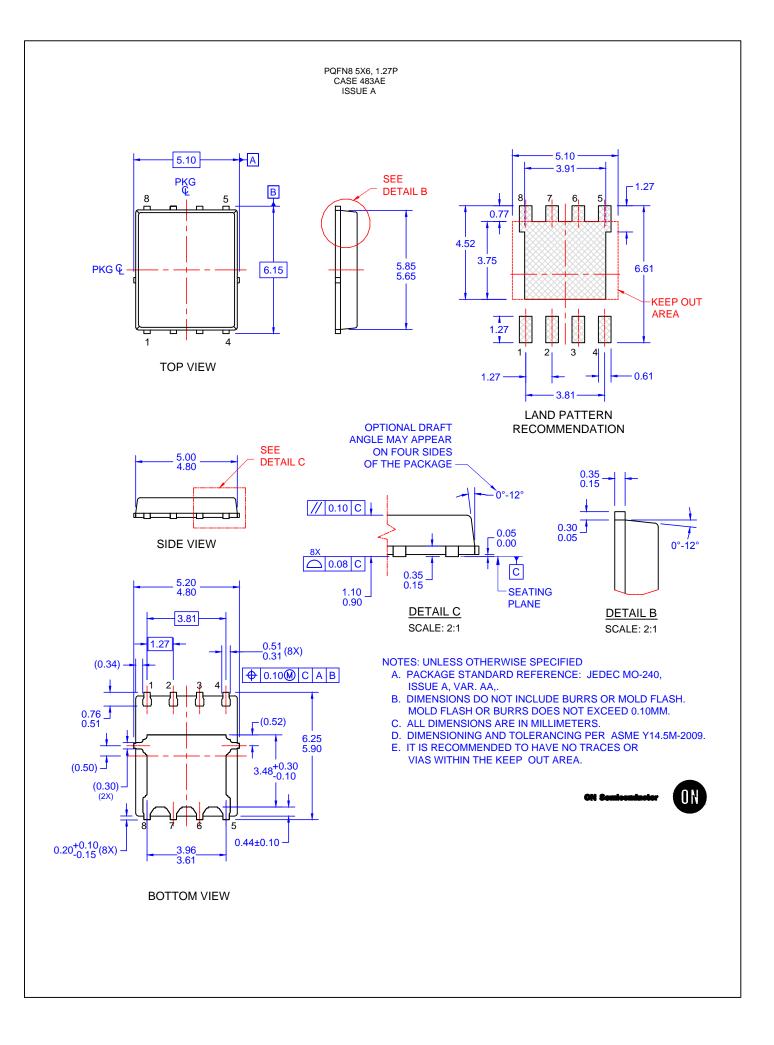


Figure 15. SyncFET body diode reverses leakage versus drain-source voltage

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